Silicon P Channel MOS FET High Speed Power Switching

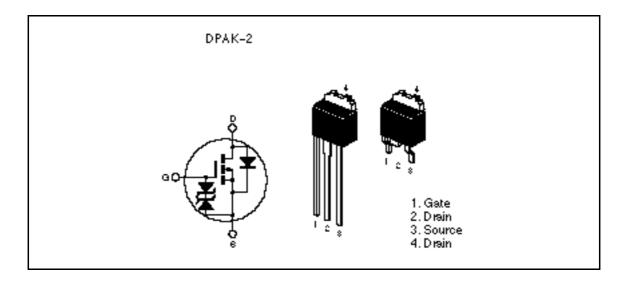
HITACHI

ADE-208-654A (Z) 2nd. Edition Jun 1998

Features

- Low on-resistance $R_{DS(on)} = 0.12$ typ.
- 4 V gete drive devices
- · High speed switching

Outline





Absolute Maximum Ratings ($Ta = 25^{\circ}C$)

| Item | Symbol | Ratings | Unit |
|--|------------------------------|-------------|------|
| Drain to source voltage | $V_{\scriptscriptstyle DSS}$ | -60 | V |
| Gate to source voltage | $V_{\rm GSS}$ | ±20 | V |
| Drain current | I _D | -10 | A |
| Drain peak current | Note1 D(pulse) | -40 | А |
| Body-drain diode reverse drain current | I _{DR} | -10 | А |
| Avalenche current | I Note3 | -10 | Α |
| Avalenche energy | E _{AR} Note3 | 8.5 | mJ |
| Channel dissipation | Pch ^{Note2} | 20 | W |
| Channel temperature | Tch | 150 | °C |
| Storage temperature | Tstg | −55 to +150 | °C |

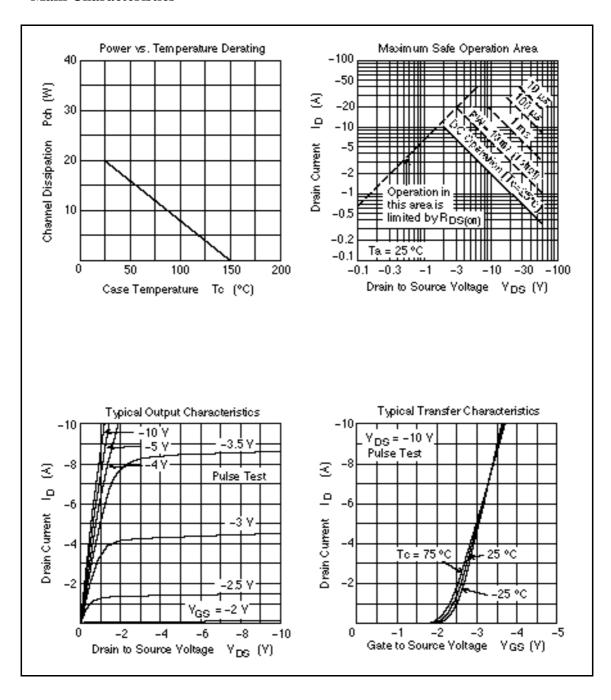
- Note: 1. PW 10 µs, duty cycle 1 %
 - 2. Value at $Tc = 25^{\circ}C$
 - 3. Value at Tch = 25°C, Rg 50

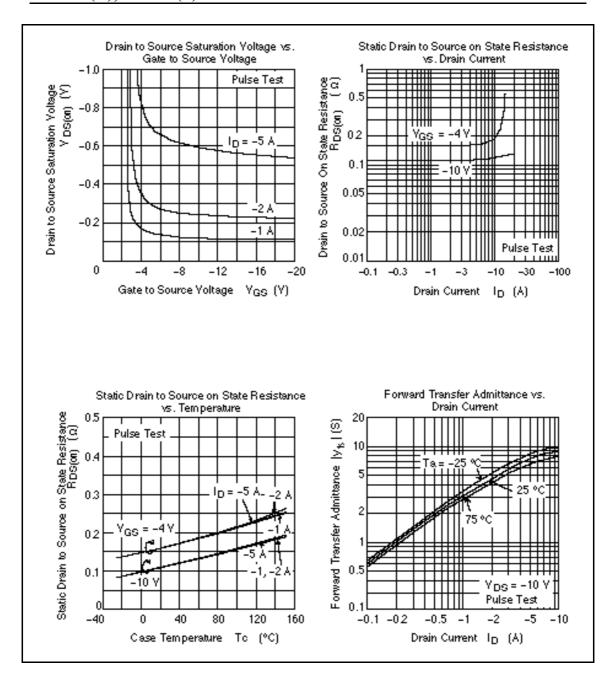
Electrical Characteristics ($Ta = 25^{\circ}C$)

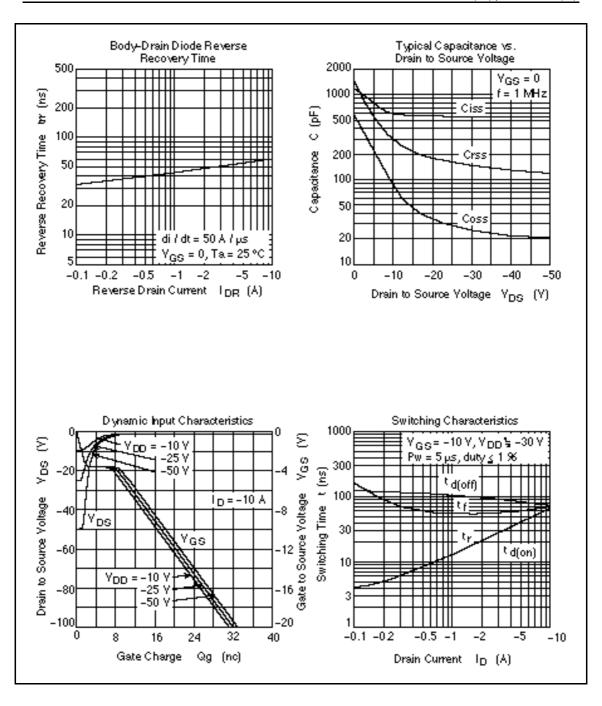
| Item | Symbol | Min | Тур | Max | Unit | Test Conditions |
|--|---------------------|------|------|------|------|---|
| Drain to source breakdown voltage | $V_{(BR)DSS}$ | -60 | _ | _ | V | $I_D = -10 \text{mA}, V_{GS} = 0$ |
| Gate to source breakdown voltage | $V_{(BR)GSS}$ | ±20 | _ | _ | V | $I_{G} = \pm 100 \mu A, V_{DS} = 0$ |
| Zero gate voltege drain current | I _{DSS} | _ | _ | -10 | μΑ | $V_{DS} = -60 \text{ V}, V_{GS} = 0$ |
| Gate to source leak current | I _{GSS} | _ | _ | ±10 | μΑ | $V_{GS} = \pm 16V, V_{DS} = 0$ |
| Gate to source cutoff voltage | $V_{GS(off)}$ | -1.0 | _ | -2.0 | V | $I_{D} = -1 \text{mA}, V_{DS} = -10 \text{V}$ |
| Static drain to source on state | R _{DS(on)} | _ | 0.12 | 0.16 | | $I_{D} = -5A, V_{GS} = -10V^{Note4}$ |
| resistance | R _{DS(on)} | _ | 0.17 | 0.24 | | $I_{D} = -5A, V_{GS} = -4V^{Note4}$ |
| Forward transfer admittance | y _{fs} | 4.5 | 7.5 | _ | S | $I_D = -5A, V_{DS} = -10V^{Note4}$ |
| Input capacitance | Ciss | _ | 580 | _ | pF | V _{DS} = -10V |
| Output capacitance | Coss | _ | 300 | _ | pF | $V_{GS} = 0$ |
| Reverse transfer capacitance | Crss | _ | 85 | _ | pF | f = 1MHz |
| Turn-on delay time | t _{d(on)} | _ | 10 | _ | ns | $V_{GS} = -10V, I_{D} = -5A$ |
| Rise time | t _r | _ | 40 | _ | ns | $R_L = 6$ |
| Turn-off delay time | $t_{d(off)}$ | _ | 85 | _ | ns | _ |
| Fall time | t _f | _ | 60 | _ | ns | _ |
| Body-drain diode forward voltage | V_{DF} | _ | -1.2 | _ | V | $I_F = -10A, V_{GS} = 0$ |
| Body-drain diode reverse recovery time | t _{rr} | _ | 60 | _ | ns | $I_F = -10A, V_{GS} = 0$ diF/ dt = 50A/µs |
| | • | | | | | |

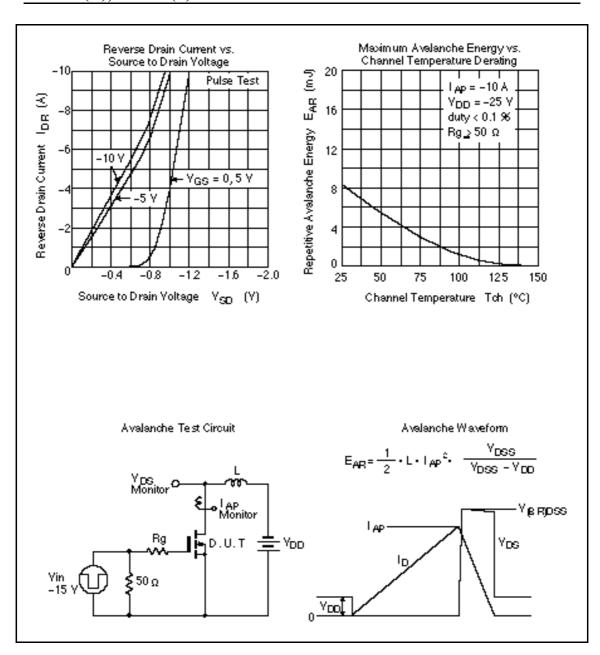
Note: 4. Pulse test

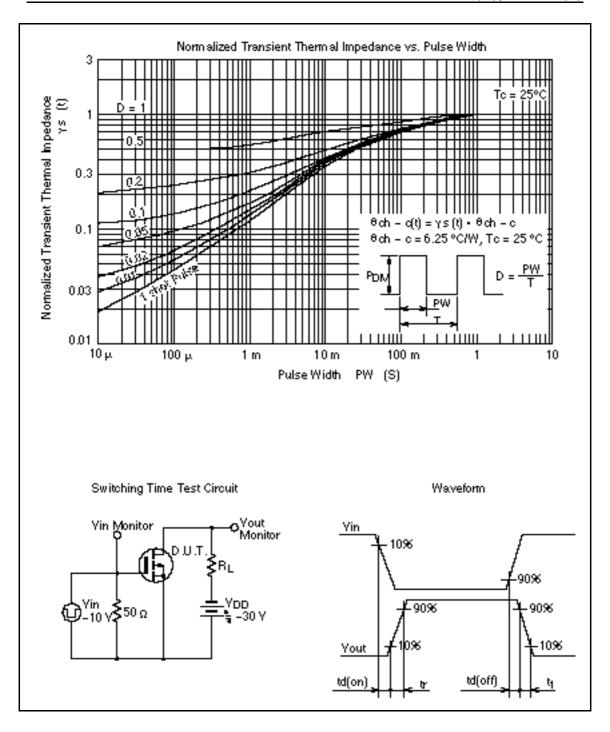
Main Characteristics





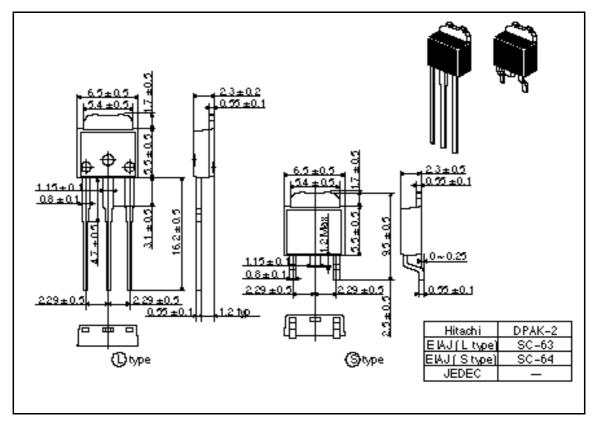






Package Dimensions

Unit: mm



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